

## PCA9560 <br> Dual 5-bit multiplexed 1-bit latched ${ }^{1}{ }^{2} \mathrm{C}$ EEPROM DIP switch

Product data sheet
Supersedes data of 2003 Jun 27


## FEATURES

- 5-bit 3-to-1 multiplexer, 1-bit latch DIP switch
- 5-bit external hardware pins
- Two 6-bit internal non-volatile registers, fully pin-to-pin compatible with PCA9559
- Selection between the two non-volatile registers
- Selection between non-volatile registers and external hardware pins
- ${ }^{2} \mathrm{C} /$ SMBus interface logic
- Internal pull-up resistors on input pin and control signals
- Active high write protect on input controls the ability to write to the non-volatile registers
- 2 address pins, allowing up to 4 devices on the $\mathrm{I}^{2} \mathrm{C}$-bus
- 5 open drain multiplexed outputs
- Open drain non-multiplexed output
- Internal 6-bit non-volatile registers programmable and readable via ${ }^{2}$ 2C-bus
- External hardware 5-bit value readable via $\mathrm{I}^{2} \mathrm{C}$-bus
- Multiplexer selection can be overridden by $\mathrm{I}^{2} \mathrm{C}$-bus
- Operating power supply voltage 3.0 V to 3.6 V
- 5 V and 2.5 V tolerant inputs/outputs
- 0 to 400 kHz clock frequency
- ESD protection exceeds 2000 V HBM per JESD22-A114, 200 V MM per JESD22-A115, and 1000 V CDM per JESD22-C101
- Latch-up testing is done to JESDEC Standard JESD78 which exceeds 100 mA .
- Package offering: SO20, TSSOP20


## DESCRIPTION

The PCA9560 is a 20 -pin CMOS device consisting of two 6-bit non-volatile EEPROM registers, 5 hardware pin inputs and a 5-bit multiplexed output with one latched EEPROM bit. It is used for DIP switch-free or jumper-less system configuration and supports Mobile and Desktop VID Configuration, where 3 preset values (2 sets of internal non-volatile registers and 1 set of external hardware pins) set processor voltage for operation in either performance, deep sleep or deeper sleep modes. The PCA9560 is also useful in server and telecom/networking applications when used to replace DIP switches or jumpers, since the settings can be easily changed via $\mathrm{I}^{2} \mathrm{C} /$ SMBus without having to power down the equipment to open the cabinet. The non-volatile memory retains the most current setting selected before the power is turned off.

The PCA9560 typically resides between the CPU and Voltage Regulator Module (VRM) when used for CPU VID (Voltage

IDentification code) configuration. It is used to bypass the CPU-defined VID values and provide a different set of VID values to the VRM, if an increase in the CPU voltage is desired. An increase in CPU voltage combined with an increase in CPU frequency leads to a performance boost of up to $7.5 \%$. Lower CPU voltage reduces power consumption. The main advantage of the PCA9560 over the older PCA9559 device in this application is that it contains two internal non-volatile EEPROM registers instead of just one, allowing three independent settings (performance operation, deep sleep mode and deeper sleep mode) instead of only two (performance operation and deep sleep mode). The PCA9560 is footprint compatible and a drop-in replacement for the PCA9559, without any software modifications required.

The PCA9560 has 2 address pins allow up to 4 devices to be placed on the same $\mathrm{I}^{2} \mathrm{C}$ bus or SMBus.

## PIN CONFIGURATION



Figure 1. Pin configuration

## PIN DESCRIPTION

| PIN | SYMBOL | FUNCTION |
| :---: | :---: | :--- |
| 1 | SCL | Serial I²C-bus clock |
| 2 | SDA | Serial bi-directional I²C-bus data |
| 3 | A1 | Programmable LSBs of I²C <br> address |
| 4 | A0 | External inputs to multiplexer |
| $5-9$ | MUX_IN A-E | Ground |
| 10 | GND | MUX <br> Selects MUX_IN inputs or register <br> contents for MUX_OUT outputs |
| 11 | SELECT_0 |  |
| $12-16$ | MUX_OUT E-A | Open drain multiplexed outputs |
| 19 | MON-MUXED_- <br> OUTPUT | Open drain output from <br> non-volatile memory |
| 19 | WELECT_1 | Selects between the two <br> non-volatile registers |
| 20 | VDD | Active high non-volatile register <br> write-protect input |

ORDERING INFORMATION

| PACKAGES | TEMPERATURE RANGE | ORDER CODE | TOPSIDE MARK | DRAWING NUMBER |
| :---: | :---: | :---: | :---: | :---: |
| 20-Pin Plastic SO | -40 to $+85^{\circ} \mathrm{C}$ | PCA9560D | PCA9560D | SOT163-1 |
| 20-Pin Plastic TSSOP | -40 to $+85^{\circ} \mathrm{C}$ | PCA9560PW | PCA9560 | SOT360-1 |

Standard packing quantities and other packaging data are available at www.philipslogic.com/packaging.

Dual 5-bit multiplexed 1-bit latched $I^{2} \mathrm{C}$ EEPROM DIP switch

BLOCK DIAGRAM


Figure 2. Block diagram

## DEVICE ADDRESS

Following a START condition the bus master must output the address of the slave it is accessing. The address of the PCA9560 is shown in Figure 3. To conserve power, no internal pull-up resistors are incorporated on the hardware selectable address pins and they must be pulled HIGH or LOW.

The last bit of the slave address byte defines the operation to be performed. When set to logic 1 a read is selected while a logic 0 selects a write operation.


## CONTROL REGISTER

Following the successful acknowledgement of the slave address, the bus master will send a byte to the PCA9560, which will be stored in the control register. This register can be written and read via the $\mathrm{I}^{2} \mathrm{C}$-bus.


Figure 4. Control Register

Figure 3. Slave address

## CONTROL REGISTER DEFINITION

Following the address and acknowledge bit with logic 0 in the read/write bit, the first byte written is the command byte. If the command byte is reserved and therefore not valid, it will not be acknowledged. Only valid command bytes will be acknowledged.

Table 1. Register Addresses

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | REGISTER <br> NAME | TYPE | REGISTER <br> FUNCTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :--- | :--- |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | EEPROM 0 | Read/Write | EEPROM byte 0 <br> register |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | EEPROM 1 | Read/Write | EEPROM byte 1 <br> register |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | MUX_IN | Read | MUX_IN values <br> register |

Table 2. Commands

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :--- |
| 1 | 1 | 1 | 1 | 1 | 0 | 0 | 0 | MUX_OUT from EEPROM byte 0 |
| 1 | 1 | 1 | 1 | 1 | 1 | 0 | 0 | MUX_OUT from EEPROM byte 1 |
| 1 | 1 | 1 | 1 | 1 | X | 1 | 0 | MUX_OUT from MUX_IN |
| 1 | 1 | 1 | 1 | 1 | X | X | 1 | MUX_OUT from MUX_SELECT $^{2}$ |

NOTE:

1. All other combinations are reserved.
2. MUX_SELECT pins select between MUX_IN and EEPROM to MUX_OUT.

## REGISTER DESCRIPTION

If the command byte is an EEPROM address, the next byte sent will be programmed into that EEPROM address on the following STOP condition, if the WP is logic 0 . If more than one byte is sent sequentially, the second byte will be written in the other-volatile register, on the following STOP condition. If any more data bytes are sent after the second byte, they will not be acknowledged and no bytes will be written to the non-volatile registers. After a byte is read from or written to the EEPROM, the part automatically points to the next non-volatile register. If the command code was FFH, the MUX_IN values are sent with the three MSBs padded with zeroes as shown below. If the command codes was 00 H , then the non-volatile register 1 is sent, and if the command code was 01 H , then the non-volatile register 1 is sent.

## EEPROM Byte 0 Register

|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Write | X | X | Non-Muxed <br> Data | EEPROM 0 <br> Data E | EEPROM 0 <br> Data D | EEPROM 0 <br> Data C | EEPROM 0 <br> Data B | EEPROM 0 <br> Data A |
| Read | 0 | 0 | Non-Muxed <br> Data | EEPROM 0 <br> Data E | EEPROM 0 <br> Data D | EEPROM 0 <br> Data C | EEPROM 0 <br> Data B | EEPROM 0 <br> Data A |
| Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

## EEPROM Byte 1 Register

|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Write | X | X | Non-Muxed <br> Data | EEPROM 1 <br> Data E | EEPROM 1 <br> Data D | EEPROM 1 <br> Data C | EEPROM 1 <br> Data B | EEPROM 1 <br> Data A |
| Read | 0 | 0 | Non-Muxed <br> Data | EEPROM 1 <br> Data E | EEPROM 1 <br> Data D | EEPROM 1 <br> Data C | EEPROM 1 <br> Data B | EEPROM 1 <br> Data A |
| Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

## MUX_IN Register

|  | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read | 0 | 0 | 0 | MUX_IN <br> DataE | MUX_IN <br> DataD | MUX_IN <br> DataC | MUX_IN <br> Data B | MUX_IN <br> DataA |

If the command byte is a MUX command byte, any additional data bytes sent after the MUX command code will not be acknowledged. If the read/write bit in the address is a logic 1, then a read operation follows and the data sent out depends on the previously stored command code.

The MUX_SELECT_1 pin can function as the over-ride pin as on the PCA9559 if the non-volatile register 1 is left at all 0 s.
The NON_MUXED_OUT pin is a latched output. It is latched when MUX_SELECT_ $0=1$. It is transparent when the MUX_SELECT_ $0=0$. The data sent out on the NON_MUXED_OUT output is the 6th most significant bit of the non-volatile register. Whether this comes from the non-volatile register 0 or non-volatile register 1 depends on the command code or the external mux-select pins.

After a valid $\mathrm{I}^{2} \mathrm{C}$ write operation to the EEPROM, the part cannot be addressed via the $\mathrm{I}^{2} \mathrm{C}$ for 3.6 ms . If the part is addressed prior to this time, the part will not acknowledge its address.

NOTE:

1. To ensure data integrity, the non-volatile register must be internally write protected when $V_{D D}$ to the $I^{2} \mathrm{C}$ bus is powered down or $\mathrm{V}_{\mathrm{DD}}$ to the component is dropped below normal operating levels.

## CONVERSION FROM THE PCA9559 TO THE PCA9560

The PCA9560 is a drop in replacement to the PCA9559 with no software modifications. The PCA9559 has only one MUX_SELECT pin to choose between the MUX_IN values and the single non-volatile register. Since the PCA9560 has two internal non-volatile registers, if Register 1 is left to all 0's (default condition) then the MUX_SELECT_1 pin can function the same as the PCA9559 OVERRIDE \# pin and MUX_SELECT_0 pin can function the same as the PCA9559 MUX_IN pin.
The PCA9560 can read the MUX_IN_X values via ${ }^{2} \mathrm{C}$ that the PACA9559 cannot do. Another difference is that the MUX_SELECT_X control pins can be overridden by ${ }^{2} \mathrm{C}$. To replace the PCA9559 with the PCA9560, the function table for the MUX_OUT outputs and the NON_MUXED_OUT output must stay the same and the MUX_SELECT pin functions should not be overridden by ${ }^{2} \mathrm{C}$.

## EXTERNAL CONTROL SIGNALS

The Write Protect (WP) input is used to control the ability to write the content of the non-volatile registers. If the WP signal is logic 0 , the $I^{2} \mathrm{C}$ bus will be able to write the contents of the non-volatile registers. If the WP signal is logic 1 , data will not be allowed to be written into the non-volatile registers. In this case, the slave address and the command code will be acknowledged but the following data bytes will not be acknowledged and the EEPROM is not updated.
The factory default for the contents of the non-volatile register are all logic 0 . These stored values can be read or written using the $\mathrm{I}^{2} \mathrm{C}$-bus (described in the next section).
The WP, MUX_IN*, MUX_SELECT_0, and MUX_SELECT_1 signals have internal pull-up resistors. See the DC and AC Characteristics for hysteresis and signal spike suppression figures.
Function Table ${ }^{1}$

| WP | MUX_SELECT_0 | MUX_SELECT_1 | COMMANDS |
| :---: | :---: | :---: | :---: |
| 0 | X | X | Write to the non-volatile registers through I²C bus allowed |
| 1 | 0 | X | Write to the non-volatile registers through IC bus not |
| allowed |  |  |  |

## NOTE:

1. This table is valid when not overridden by $\mathrm{I}^{2} \mathrm{C}$ control register.

## POWER-ON RESET (POR)

When power is applied to $\mathrm{V}_{\mathrm{DD}}$, an internal power-on reset holds the PCA9560 in a reset state until $\mathrm{V}_{\mathrm{DD}}$ has reached $\mathrm{V}_{\text {POR }}$. At that point, the reset condition is released and the PCA9560 volatile registers and $I^{2} \mathrm{C} /$ SMBus state machine will initialize to their default states.
The MUX_OUT and NON_MUXED_OUT pin values depend on:

- the MUX_SELECT_0 and MUX_SELECT_1 logic levels, selecting either the MUX_IN input pins or one of the two 6-bit EEPROMs
- the previously stored values in the EEPROM registers/current MUX_IN pin values as shown in the Function Table

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## CHARACTERISTICS OF THE I²C-BUS

The $I^{2}$ C-bus is for 2-way, 2-line communication between different ICs or modules. The two lines are a serial data line (SDA) and a serial clock line (SCL). Both lines must be connected to a positive supply via a pull-up resistor when connected to the output stages of a device. Data transfer may be initiated only when the bus is not busy.

## Bit transfer

One data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the HIGH period of the clock pulse as changes in the data line at this time will be interpreted as control signals (see Figure 5).


Figure 5. Bit transfer

## Start and stop conditions

Both data and clock lines remain HIGH when the bus is not busy. A HIGH-to-LOW transition of the data line, while the clock is HIGH is defined as the start condition (S). A LOW-to-HIGH transition of the data line while the clock is HIGH is defined as the stop condition (P) (see Figure 6).

## System configuration

A device generating a message is a 'transmitter', a device receiving is the 'receiver'. The device initiates a transfer is the 'master' and the devices which are controlled by the master are the 'slaves' (see Figure 7).


Figure 6. Definition of start and stop conditions


Figure 7. System configuration

## Dual 5-bit multiplexed 1-bit latched

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## Acknowledge

The number of data bytes transferred between the start and the stop conditions from transmitter to receiver is not limited. Each byte of eight bits is followed by one acknowledge bit. The acknowledge bit is a HIGH-level put on the bus by the transmitter whereas the master generates an extra acknowledge related clock pulse.

A slave receiver which is addressed must generate an acknowledge after the reception of each byte. Also a master must generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter. The device that acknowledges has to pull down the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during the HIGH period of the acknowledge related clock pulse, set-up and hold times must be taken into account.
A receiver must signal an end of data to the transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this event, the transmitter must leave the data line HIGH to enable the master to generate a stop condition.


Figure 8. Acknowledgement on the $\mathrm{I}^{2} \mathrm{C}$-bus

## Bus Transactions

Data is transmitted to the PCA9560 registers using Write Byte transfers (see Figures 9 and 10). Data is read from the PCA9560 registers using Read and Receive Byte transfers (see Figure 11).


Figure 9. WRITE on 1 EEPROM - assuming WP $=0$


Figure 10. WRITE on 2 EEPROMs - assuming WP $=0$


Figure 11. READ MUX_IN register

## ABSOLUTE MAXIMUM RATINGS ${ }^{1,2}$

In accordance with the Absolute Maximum Rating System (IEC 134)
Voltages are referenced to GND (ground $=0 \mathrm{~V}$ )

| SYMBOL | PARAMETER | CONDITIONS | RATING | UNIT |
| :---: | :--- | :--- | ---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | DC supply voltage | -0.5 to +4.0 | V |  |
| $\mathrm{~V}_{\text {IN }}$ | DC input voltage | Note 3 | -0.5 to +5.5 | V |
| $\mathrm{~V}_{\text {OUT }}$ | DC output voltage | Note 3 | -0.5 to +5.5 | V |
| $\mathrm{~T}_{\text {Stg }}$ | Storage temperature range |  | -60 to +150 | ${ }^{\circ} \mathrm{C}$ |

## NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed $150^{\circ} \mathrm{C}$.
3. The maximum input or output voltage is the lesser of 5.5 V or $\mathrm{V}_{\mathrm{DD}}+4.0 \mathrm{~V}$, except for very short (e.g., system start-up or shut-down) durations.

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER |  | CONDITIONS | LIMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | MAX |  |
| $\mathrm{V}_{\mathrm{DD}}$ | DC supply voltage |  |  | - | 3.0 | 3.6 | V |
| $\mathrm{V}_{\text {IL }}$ | LOW-level input voltage | SCL, SDA | $\mathrm{l} \mathrm{OL}=3 \mathrm{~mA}$ | -0.5 | 0.9 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | HIGH-level input voltage | SCL, SDA | $\mathrm{I}_{\mathrm{OL}}=3 \mathrm{~mA}$ | 2.7 | $5.5{ }^{1}$ | V |
| $\mathrm{V}_{\text {OL }}$ | LOW-level output voltage | SCL, SDA | $\mathrm{l} \mathrm{OL}=3 \mathrm{~mA}$ | - | 0.4 | V |
|  |  |  | $\mathrm{l}_{\mathrm{OL}}=6 \mathrm{~mA}$ | - | 0.6 |  |
| VIL | LOW-level input voltage | MUX IN, MUX SELECT 0, MUX_SELECT_1 | - | -0.5 | 0.8 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | HIGH-level input voltage | MUX IN, MUX SELECT_0, MUX_SELECT﹎﹎́1 | - | 2.0 | $5.5{ }^{1}$ | V |
| loL | LOW-level output current | MUX OUT, NON_MUXXED_OUT | - | - | 8 | mA |
| IOH | HIGH-level output current | MUX_OUT, NON_MUXXED_OUT | - | - | 100 | $\mu \mathrm{A}$ |
| dt/dv | Input transition rise or fall time | dt/dv | - | 0 | 10 | ns/V |
| $\mathrm{T}_{\text {amb }}$ | Operating ambient temperature | $\mathrm{T}_{\text {amb }}$ | - | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |

## NOTES:

1. The maximum input voltage is the lesser of 5.5 V or $\mathrm{V}_{\mathrm{DD}}+4.0 \mathrm{~V}$, except for very short (e.g., system start-up or shut-down) durations.

## DC CHARACTERISTICS

| SYMBOL | PARAMETER | TEST CONDITION | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN. | TYP. | MAX. |  |
| Supply |  |  |  |  |  |  |
| VDD | Supply voltage |  | 3 | - | 3.6 | V |
| IDDL | Supply current | Operating mode ALL inputs $=0 \mathrm{~V}$ | - | - | 1 | mA |
| $\mathrm{I}_{\text {DDH }}$ | Supply current | Operating mode ALL inputs $=\mathrm{V}_{\mathrm{DD}}$ | - | - | 600 | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\text {POR }}$ | Power-on reset voltage | No load; $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{DD}}$ or GND | - | 2.3 | 2.7 | V |
| Input SCL: Input/Output SDA |  |  |  |  |  |  |
| $\mathrm{V}_{\text {IL }}$ | LOW-level input voltage |  | -0.5 | - | 0.8 | V |
| $\mathrm{V}_{1 \mathrm{H}}$ | HIGH-level input voltage |  | 2 | - | $5.5{ }^{1}$ | V |
| $\mathrm{l}_{\text {OL }}$ | LOW-level output current | $\mathrm{V}_{\mathrm{OL}}=0.4 \mathrm{~V}$ | 3 | - | - | mA |
| $\mathrm{l}_{\text {OL }}$ | LOW-level output current | $\mathrm{V}_{\mathrm{OL}}=0.6 \mathrm{~V}$ | 6 | - | - | mA |
| $\mathrm{I}_{\mathrm{H}}$ | Leakage current HIGH | $\mathrm{V}_{1}=\mathrm{V}_{\mathrm{DD}}$ | -1 | - | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {LL }}$ | Input current LOW | $\mathrm{V}_{1}=$ GND | -1 | - | 1 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{1}$ | Input capacitance |  | - | 3 | 6 | pF |

WP, MUX_SELECT_0, MUX_SELECT_1

| $I_{I H}$ | Leakage current HIGH | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{DD}}$ | -1 | - | 1 | $\mu \mathrm{~A}$ |
| :--- | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{IL}}$ | Input current LOW | $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ | -20 | - | -50 | $\mu \mathrm{~A}$ |
| $\mathrm{C}_{\mathrm{I}}$ | Input capacitance |  | - | 2.5 | 5 | pF |

## MUX_IN A $\rightarrow$ E

| $I_{I H}$ | Leakage current HIGH | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{DD}}$ | -1 | - | 1 | $\mu \mathrm{~A}$ |
| :--- | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{IL}}$ | Input current LOW | $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ | -20 | - | -50 | $\mu \mathrm{~A}$ |
| $\mathrm{C}_{\mathrm{I}}$ | Input capacitance |  | - | 2.5 | 5 | pF |

A0, A1 Inputs

| $\mathrm{IIH}^{\text {H }}$ | Leakage current HIGH | $\mathrm{V}_{1}=\mathrm{V}_{\mathrm{DD}}$ | -1 | - | 1 | $\mu \mathrm{A}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| IIL | Input current LOW | $\mathrm{V}_{\mathrm{DD}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ | -20 | - | -50 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{1}$ | Input capacitance |  | - | 2 | 4 | pF |
| MUX_OUT |  |  |  |  |  |  |
| $\mathrm{V}_{\text {OL }}$ | LOW-level output voltage | l OL $=100 \mu \mathrm{~A}$ | - | - | 0.4 | V |
| $\mathrm{V}_{\text {OL }}$ | LOW-level output voltage | $\mathrm{l} \mathrm{OL}=4 \mathrm{~mA}$ | - | - | 0.7 | V |
| $\mathrm{I}_{\mathrm{OH}}$ | HIGH-level output current | $\mathrm{V}_{\mathrm{OH}}=\mathrm{V}_{\mathrm{DD}}$ | - | - | 100 | $\mu \mathrm{A}$ |
| NON-MUXED_OUT |  |  |  |  |  |  |
| $\mathrm{V}_{\text {OL }}$ | LOW-level output voltage | $\mathrm{l} \mathrm{OL}=100 \mu \mathrm{~A}$ | - | - | 0.4 | V |
| $\mathrm{V}_{\text {OL }}$ | LOW-level output voltage | $\mathrm{l} \mathrm{OL}=2 \mathrm{~mA}$ | - | - | 0.7 | V |

## NOTE:

1. The maximum input voltage is the lesser of 5.5 V or $\mathrm{V}_{\mathrm{DD}}+4.0 \mathrm{~V}$, except for very short (e.g., system start-up or shut-down) durations.

## NON-VOLATILE STORAGE SPECIFICATIONS

| PARAMETER | SPECIFICATION |
| :---: | :---: |
| Memory cell data retention | 10 years min |
| Number of memory cell write cycles | 100,000 cycles min |

[^0]Dual 5-bit multiplexed 1-bit latched $I^{2} \mathrm{C}$ EEPROM DIP switch

## SAC CHARACTERISTICS

| SYMBOL | PARAMETER | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN. | TYP. | MAX. |  |
| MUX_IN $\Rightarrow$ MUX_OUT |  |  |  |  |  |
| $\mathrm{t}_{\text {PLH }}$ | LOW-to-HIGH transition time | - | 28 | 40 | ns |
| $\mathrm{t}_{\text {PHL }}$ | HIGH-to-LOW transition time | - | 8 | 15 | ns |
| Select $\Rightarrow$ MUX_OUT |  |  |  |  |  |
| tpLH | LOW-to-HIGH transition time | - | 30 | 43 | ns |
| $\mathrm{t}_{\text {PHL }}$ | HIGH-to-LOW transition time | - | 10 | 15 | ns |
| $\mathrm{t}_{\mathrm{R}}$ | Output rise time | 1.0 | - | 3 | ns/V |
| $\mathrm{t}_{\text {F }}$ | Output fall time | 1.0 | - | 3 | $\mathrm{ns} / \mathrm{V}$ |
| $\mathrm{C}_{\mathrm{L}}$ | Test load capacitance on outputs | - | - | 50 | pF |
| Select $\Rightarrow$ NON-MUXED_OUT |  |  |  |  |  |
| tpLH | LOW-to-HIGH transition time | - | 30 | 40 | ns |
| $\mathrm{t}_{\text {PHL }}$ | HIGH-to-LOW transition time | - | 9 | 15 | ns |

## AC SPECIFICATIONS

| SYMBOL | PARAMETER | STANDARD MODE $1^{2} \mathrm{C}$-BUS |  | $\begin{aligned} & \text { FAST MODE } \\ & \text { I²C-BUS } \end{aligned}$ |  | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | MAX | MIN | MAX |  |
| $\mathrm{f}_{\text {SCL }}$ | Operating frequency | 0 | 100 | 0 | 400 | kHz |
| $\mathrm{t}_{\text {BUF }}$ | Bus free time between STOP and START conditions | 4.7 | - | 1.3 | - | $\mu \mathrm{s}$ |
| $t_{\text {HD } ; \text { STA }}$ | Hold time after (repeated) START condition | 4.0 | - | 0.6 | - | $\mu \mathrm{s}$ |
| tsu;STA | Repeated START condition setup time | 4.7 | - | 0.6 | - | $\mu \mathrm{s}$ |
| tsu;Sto | Set-up time for STOP condition | 4.0 | - | 0.6 | - | $\mu \mathrm{S}$ |
| $\mathrm{thD}^{\text {dat }}$ | Data in hold time | 0 | - | 0 | - | ns |
| tvo;ACK | Valid time for ACK condition ${ }^{2}$ | 0.3 | 3.45 | 0.1 | 0.9 | $\mu \mathrm{S}$ |
| tvD;DAT | Data out valid time ${ }^{3}$ | 300 | - | 50 | - | ns |
| ${ }_{\text {t }}$ U;DAT | Data set-up time | 250 | - | 100 | - | ns |
| tow | Clock LOW period | 4.7 | - | 1.3 | - | $\mu \mathrm{s}$ |
| thigh | Clock HIGH period | 4.0 | - | 0.6 | - | $\mu \mathrm{S}$ |
| $\mathrm{t}_{\mathrm{F}}$ | Clock/Data fall time | - | 300 | $20+0.1 \mathrm{C}{ }^{1}$ | 300 | ns |
| $\mathrm{t}_{\mathrm{R}}$ | Clock/Data rise time | - | 1000 | $20+0.1 \mathrm{C}^{1}{ }^{1}$ | 300 | ns |
| $\mathrm{t}_{\text {SP }}$ | Pulse width of spikes that must be suppressed by the input filters | - | 50 | - | 50 | ns |

## NOTES:

1. $\mathrm{C}_{\mathrm{b}}=$ total capacitance of one bus line in pF .
2. $\mathrm{t}_{\mathrm{VD} ; \mathrm{ACK}}=$ time for Acknowledgement signal from SCL LOW to SDA (out) LOW.
3. $\mathrm{t}_{\mathrm{VD} ; \mathrm{DAT}}=$ minimum time for SDA data out to be valid following SCL LOW.

Dual 5-bit multiplexed 1-bit latched $I^{2} \mathrm{C}$ EEPROM DIP switch


SU00645
Figure 12. Definition of timing


Figure 13. Open drain output enable and disable times


Figure 14. Test circuit

Dual 5-bit multiplexed 1-bit latched


DIMENSIONS (inch dimensions are derived from the original mm dimensions)

| UNIT | $\begin{gathered} \mathrm{A} \\ \text { max. } \end{gathered}$ | $\mathrm{A}_{1}$ | $\mathrm{A}_{2}$ | $\mathrm{A}_{3}$ | $\mathrm{b}_{\mathrm{p}}$ | c | $\mathrm{D}^{(1)}$ | $E^{(1)}$ | e | $\mathrm{HE}_{\mathrm{E}}$ | L | $L_{p}$ | Q | v | w | y | $z^{(1)}$ | $\theta$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 2.65 | $\begin{aligned} & 0.3 \\ & 0.1 \end{aligned}$ | $\begin{aligned} & 2.45 \\ & 2.25 \end{aligned}$ | 0.25 | $\begin{aligned} & 0.49 \\ & 0.36 \end{aligned}$ | $\begin{aligned} & 0.32 \\ & 0.23 \end{aligned}$ | $\begin{aligned} & 13.0 \\ & 12.6 \end{aligned}$ | $\begin{aligned} & 7.6 \\ & 7.4 \end{aligned}$ | 1.27 | $\begin{aligned} & 10.65 \\ & 10.00 \end{aligned}$ | 1.4 | $\begin{aligned} & 1.1 \\ & 0.4 \end{aligned}$ | $\begin{aligned} & 1.1 \\ & 1.0 \end{aligned}$ | 0.25 | 0.25 | 0.1 | $\begin{aligned} & 0.9 \\ & 0.4 \end{aligned}$ | $\begin{aligned} & 8^{0} \\ & 0^{\circ} \end{aligned}$ |
| inches | 0.1 | $\begin{aligned} & 0.012 \\ & 0.004 \end{aligned}$ | $\begin{aligned} & 0.096 \\ & 0.089 \end{aligned}$ | 0.01 | $\begin{aligned} & 0.019 \\ & 0.014 \end{aligned}$ | $\begin{aligned} & 0.013 \\ & 0.009 \end{aligned}$ | $\begin{aligned} & 0.51 \\ & 0.49 \end{aligned}$ | $\begin{aligned} & 0.30 \\ & 0.29 \end{aligned}$ | 0.05 | $\begin{aligned} & 0.419 \\ & 0.394 \end{aligned}$ | 0.055 | $\begin{aligned} & 0.043 \\ & 0.016 \end{aligned}$ | $\begin{aligned} & 0.043 \\ & 0.039 \end{aligned}$ | 0.01 | 0.01 | 0.004 | $\begin{aligned} & 0.035 \\ & 0.016 \end{aligned}$ |  |

Note

1. Plastic or metal protrusions of $0.15 \mathrm{~mm}(0.006 \mathrm{inch})$ maximum per side are not included.

| OUTLINE <br> VERSION | REFERENCES |  |  | EUROPEAN | PROJECTION |
| :---: | :---: | :---: | :---: | :---: | :---: | ISSUE DATE

Dual 5-bit multiplexed 1-bit latched


DIMENSIONS ( mm are the original dimensions)

| UNIT | $\mathbf{A}$ <br> max. | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(1)}$ | $\mathbf{E}^{(2)}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{Q}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}^{(1)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.1 | 0.15 | 0.95 | 0.25 | 0.30 | 0.2 | 6.6 | 4.5 | 0.6 | 6.6 | 1 | 0.75 | 0.4 | 0.2 | 0.13 | 0.1 | 0.5 |

## Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

| OUTLINE VERSION | REFERENCES |  |  | EUROPEAN PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | JEITA |  |  |
| SOT360-1 |  | MO-153 |  |  | $\begin{gathered} -9-12-27 \\ 03-02-19 \end{gathered}$ |

Dual 5-bit multiplexed 1-bit latched $I^{2} \mathrm{C}$ EEPROM DIP switch

## REVISION HISTORY

| Rev | Date | Description |
| :---: | :---: | :---: |
| -4 | 20040519 | Product data sheet (9397 750 13154). Supersedes data of 2003 Jun 27 (9397 750 11676). <br> Modifications: <br> - Features section, $16^{\text {th }}$ bullet: from "inputs" to "inputs/outputs" <br> - Absolute maximum ratings table: $\mathrm{V}_{\mathrm{DD}}, \mathrm{V}_{\mathrm{IN}}$, and $\mathrm{V}_{\mathrm{OUT}}$ limits modified. Note 3 re-written. <br> - Recommended operating conditions <br> - $\mathrm{V}_{\mathbb{I H}}$ max. (on SCL, SDA) changed from 4.0 V to 5.5 V (with Note 1 added). <br> - $\mathrm{V}_{\mathrm{IH}}$ max. (on MUX_IN, MUX_SELECT_0, MUX_SELECT_1) changed from 4.0 V to 5.5 V (with Note 1 added). <br> - DC characteristics table: Input SCL: Input/Output SDA; $\mathrm{V}_{\mathrm{IH}}$ parameter max. limit modified, and Note 1 added. |
| -3 | 20030627 | Product data (9397 750 11676); ECN 853-2286 29936 dated 19 May 2003. Supersedes data of 2002 May 24 ( 9397750 09892). |
| -2 | 20020524 | Product data (9397 750 09892); ECN 853-2286 28310 of 24 May 2002. |



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## Data sheet status

| Level | Data sheet status [1] | Product <br> status [2] [3] | Definitions |
| :--- | :--- | :--- | :--- |
| I | Objective data sheet | Development | This data sheet contains data from the objective specification for product development. <br> Philips Semiconductors reserves the right to change the specification in any manner without notice. |
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## Definitions

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.
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[^0]:    Application Note AN250 I²C DIP Switch provides additional information on memory cell data retention and the minimum number of write cycles.

